Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/691,136	FANG ET AL.	
Examiner	Art Unit	
Nema O. Berezny	2813	

SEARCHED					
Class	Subclass	Date	Examiner		
438	108	3/12/2005	NB ∩B		
257	778				
228	180.22	4	$\overline{\Psi}$		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
438	108	3/14/2005	NB		
257	778				
228	180.22		V		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See printout	3/12/2005	NB NB		
Examiner files		→		